

# Single N-channel MOSFET

ELM32402LA-S

## General description

ELM32402LA-S uses advanced trench technology to provide excellent  $R_{ds(on)}$ , low gate charge and low gate resistance.

## Features

- $V_{ds}=20V$
- $I_d=20A$
- $R_{ds(on)} < 50m\Omega$  ( $V_{gs}=5V$ )
- $R_{ds(on)} < 85m\Omega$  ( $V_{gs}=2.5V$ )

## Maximum absolute ratings

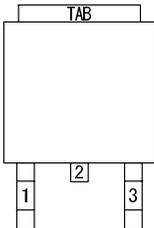
Parameter	Symbol	Limit	Unit	Note
Gate-source voltage	$V_{gs}$	$\pm 16$	V	
Continuous drain current	$I_d$	20	A	
		13		
Pulsed drain current	$I_{dm}$	40	A	3
Power dissipation	$P_d$	26	W	
		11		
Junction and storage temperature range	$T_j, T_{stg}$	-55 to 150	$^{\circ}C$	

## Thermal characteristics

Parameter		Symbol	Typ.	Max.	Unit	Note
Maximum junction-to-case	Steady-state	$R\theta_{jc}$		4.8	$^{\circ}C/W$	
Maximum junction-to-ambient	Steady-state	$R\theta_{ja}$		110.0	$^{\circ}C/W$	

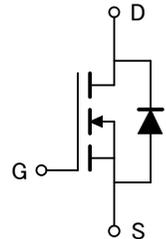
## Pin configuration

TO-252-3 (TOP VIEW)



Pin No.	Pin name
1	GATE
2	DRAIN
3	SOURCE

## Circuit



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## Electrical characteristics

T<sub>a</sub>=25°C

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit	Note
<b>STATIC PARAMETERS</b>							
Drain-source breakdown voltage	BV <sub>dss</sub>	I <sub>d</sub> =250 μA, V <sub>gs</sub> =0V	20			V	
Zero gate voltage drain current	I <sub>dss</sub>	V <sub>ds</sub> =16V, V <sub>gs</sub> =0V			1	μA	
		V <sub>ds</sub> =13.2V, V <sub>gs</sub> =0V, T <sub>j</sub> =125°C			10		
Gate-body leakage current	I <sub>gss</sub>	V <sub>ds</sub> =0V, V <sub>gs</sub> =±16V			±100	nA	
Gate threshold voltage	V <sub>gs(th)</sub>	V <sub>ds</sub> =V <sub>gs</sub> , I <sub>d</sub> =250 μA	0.45	0.75	1.00	V	
On state drain current	I <sub>d(on)</sub>	V <sub>gs</sub> =4.5V, V <sub>ds</sub> =10V	20			A	1
Static drain-source on-resistance	R <sub>ds(on)</sub>	V <sub>gs</sub> =5V, I <sub>d</sub> =6A		37	50	mΩ	1
		V <sub>gs</sub> =2.5V, I <sub>d</sub> =5A		55	85	mΩ	
Forward transconductance	G <sub>fs</sub>	V <sub>ds</sub> =10V, I <sub>d</sub> =6A		13		S	1
Diode forward voltage	V <sub>sd</sub>	I <sub>f</sub> =I <sub>s</sub> , V <sub>gs</sub> =0V			1.3	V	1
Max. body-diode continuous current	I <sub>s</sub>				20	A	
Pulsed body-diode current	I <sub>sm</sub>				40	A	3
<b>DYNAMIC PARAMETERS</b>							
Input capacitance	C <sub>iss</sub>	V <sub>gs</sub> =0V, V <sub>ds</sub> =15V, f=1MHz		195		pF	
Output capacitance	C <sub>oss</sub>			125		pF	
Reverse transfer capacitance	C <sub>rss</sub>			50		pF	
<b>SWITCHING PARAMETERS</b>							
Total gate charge	Q <sub>g</sub>	V <sub>gs</sub> =5V, V <sub>ds</sub> =10V, I <sub>d</sub> =10A		7.5		nC	2
Gate-source charge	Q <sub>gs</sub>			0.9		nC	2
Gate-drain charge	Q <sub>gd</sub>			4.0		nC	2
Turn-on delay time	t <sub>d(on)</sub>	V <sub>gs</sub> =5V, V <sub>ds</sub> =10V, I <sub>d</sub> ≈ 1A R <sub>l</sub> =1 Ω, R <sub>gen</sub> =3.3 Ω		4.5		ns	2
Turn-on rise time	t <sub>r</sub>			49.5		ns	2
Turn-off delay time	t <sub>d(off)</sub>			12.0		ns	2
Turn-off fall time	t <sub>f</sub>			6.0		ns	2

### NOTE :

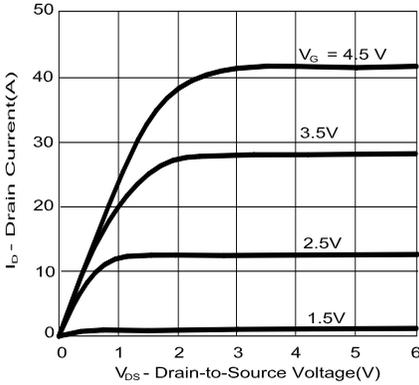
1. Pulse test : Pulsed width ≤ 300 μsec and Duty cycle ≤ 2%.
2. Independent of operating temperature.
3. Pulsed width limited by maximum junction temperature.

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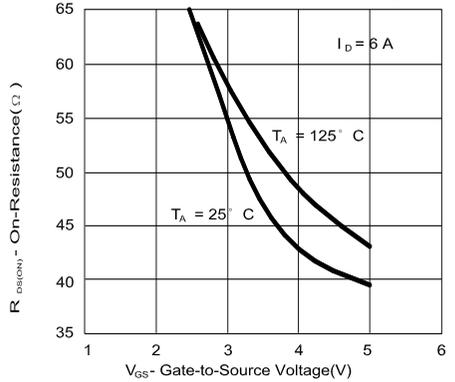
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### Typical electrical and thermal characteristics

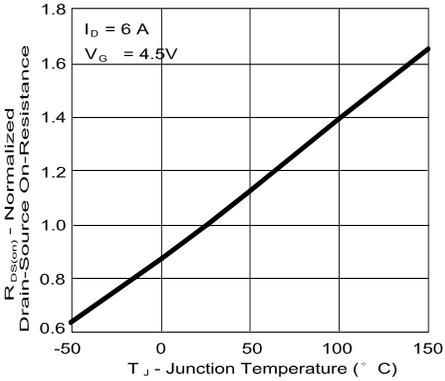
Typical output characteristics



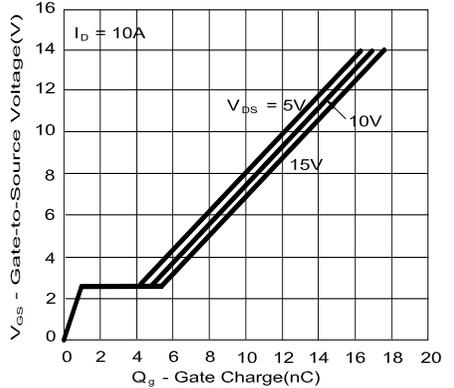
On-Resistance v.s. Gate Voltage



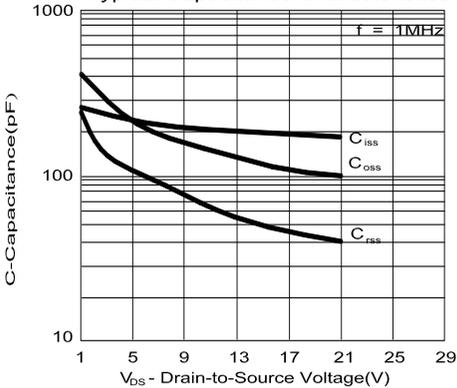
Normalized on-Resistance v.s. Junction Temperature



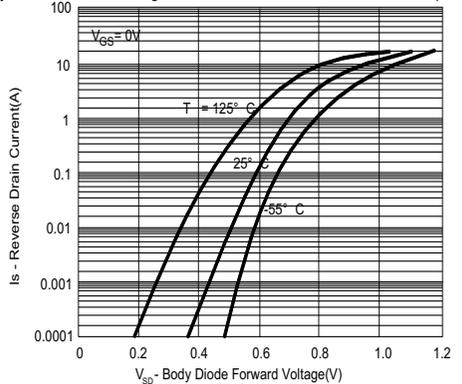
Gate Charge Characteristics



Typical Capacitance Characteristics



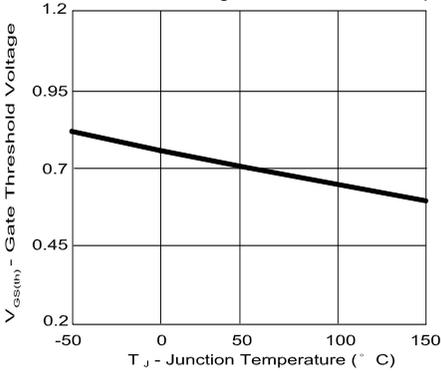
Body Diode Forward Voltage Variation with Source Current and Temperature



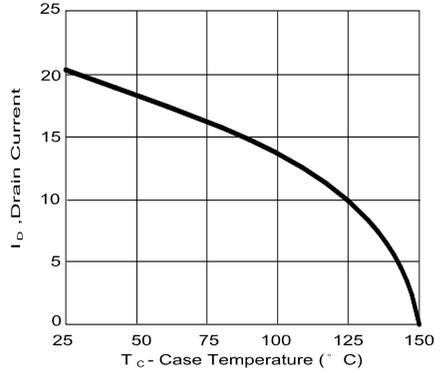
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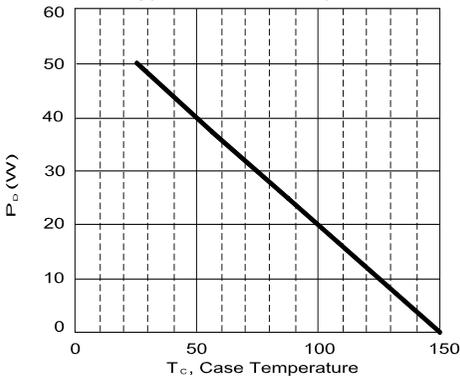
Gate Threshold Voltage v.s. Junction Temperature



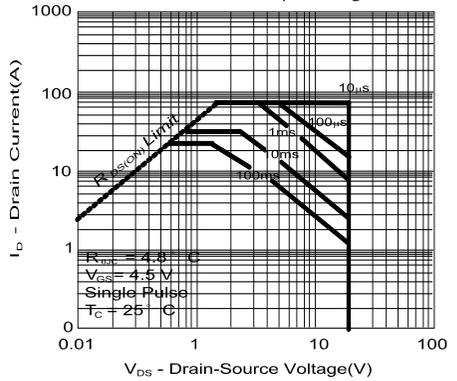
Maximum Drain Current v.s. Case Temperature



Typical Power Dissipation



Maximum Safe Operating Area



Effective Transient Thermal Impedance

